

# **PSMN013-40VLD**

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

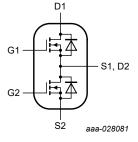
14 December 2023

Product data sheet

### 1. General description

Dual, logic level N-channel MOSFET in an LFPAK56D package (half-bridge configuration), using NextpowerS3 technology.

An internal connection is made between the source (S1) of the high-side FET to the drain (D2) of the low-side FET, making the device ideal to use as a half-bridge switch in high-performance PWM and space constrained motor drive applications



#### 2. Features and benefits

- LFPAK56D package with half-bridge configuration enables:
  - Reduced PCB layout complexity
  - · Module shrinkage through reduced component count
  - Improved system level R<sub>th(j-amb)</sub> due to optimized package design
  - Lower parasitic inductance to support higher efficiency
  - Footprint compatibility with LFPAK56D Dual package
- NextpowerS3 technology
- Low power losses, high power density
- Superior avalanche performance
- · Repetitive avalanche rated
- LFPAK copper clip packaging provides high robustness and reliability
- · Gull wing leads support high manufacturability and Automated Optical Inspection (AOI)

## 3. Applications

- · Handheld power tools, portable appliance and space constrained applications
- · Brushless or brushed DC motor drive
- DC-to-DC systems
- LED lighting

#### 4. Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Limiting values	s FET1 and FET2						
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		-	-	40	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	[1]	-	-	42	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	-	46	W



Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static characte	Static characteristics FET1 and FET2						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C}; Fig. 8$		-	11.35	13.6	mΩ
Dynamic chara	cteristics FET1 and FE	Γ2			•		
$Q_{GD}$	gate-drain charge	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V; Fig. 10; Fig. 11		0.6	2.1	4.2	nC
Source-drain d	Source-drain diode FET1 and FET2						
Q <sub>r</sub>	recovered charge	$I_S = 10 \text{ A}; \text{ d}I_S/\text{d}t = -100 \text{ A/}\mu\text{s}; \text{ V}_{GS} = 0 \text{ V}; \\ \text{V}_{DS} = 20 \text{ V}; \text{Fig. } 14$		-	16.2	-	nC

<sup>[1] 43</sup>A Continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

## 5. Pinning information

**Table 2. Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S2	source2	8 7 6 5	
2	G2	gate2	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	D1 
3	S1	source1		
4	G1	gate1		G1 I
5	D1	drain1		\$1, D2
6	D1	drain1		G2 LIFT
7	S1, D2	source1, drain2	1 2 3 4	
8	S1, D2	source1, drain2	LFPAK56D; Dual LFPAK (SOT1205)	S2 <sub>aaa-028081</sub>

## 6. Ordering information

**Table 3. Ordering information** 

Type number	Package				
	Name	Description	Version		
PSMN013-40VLD	LFPAK56D; Dual LFPAK	plastic, single ended surface mounted package (LFPAK56D); 8 leads	SOT1205		

### 7. Marking

#### Table 4. Marking codes

Type number	Marking code
PSMN013-40VLD	13DL40V

## 8. Limiting values

#### **Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Limiting val	ues FET1 and FET2			<u> </u>		
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		-	40	V
$V_{DSM}$	peak drain-source voltage	$t_p$ = 20 ns; f = 500 kHz; $E_{DS(AL)}$ = 200 nJ; pulsed		-	45	V
$V_{DGR}$	drain-gate voltage	25 °C ≤ Tj ≤ 175 °C; RGS = 20 kΩ		-	40	V
V <sub>GS</sub>	gate-source voltage			-20	20	V
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	46	W
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	[1]	-	42	Α
		V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C		-	30	А
I <sub>DM</sub>	peak drain current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 °C$ ; Fig. 3		-	169	Α
T <sub>stg</sub>	storage temperature			-55	175	°C
T <sub>j</sub>	junction temperature			-55	175	°C
$T_{sld(M)}$	peak soldering temperature			-	260	°C
Source-drai	n diode FET1 and FET2				•	
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C		-	42	Α
I <sub>SM</sub>	peak source current	pulsed; t <sub>p</sub> ≤ 10 μs; T <sub>mb</sub> = 25 °C		-	169	А
Avalanche r	uggedness FET1 and FET2					
E <sub>DS(AL)S</sub>	non-repetitive drain- source avalanche energy	$I_D$ = 39.9 A; $V_{sup} \le 40$ V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped; $t_p$ = 9 μs		-	10.6	mJ
I <sub>AS</sub>	non-repetitive avalanche current	$V_{sup}$ = 40 V; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $R_{GS}$ = 50 $\Omega$	[2]	-	39.9	А

<sup>[1] 43</sup>A Continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

<sup>[2]</sup> Protected by 100% test

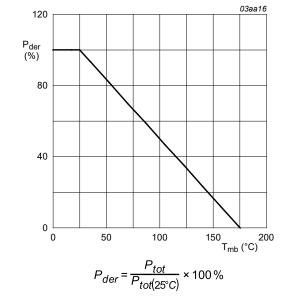
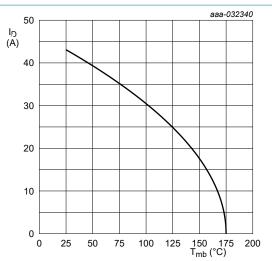
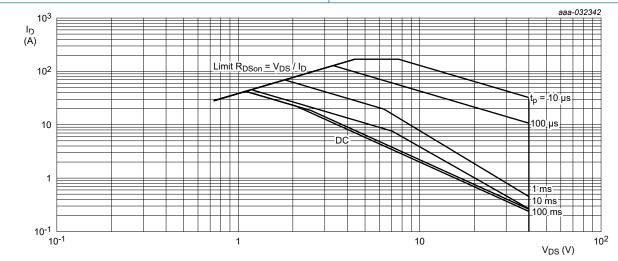


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 5 \text{ V}$  42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2



 $T_{mb}$  = 25 °C;  $I_{DM}$  is a single pulse

Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage, FET1 and

### 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	<u>Fig. 4</u>	-	3	3.23	K/W

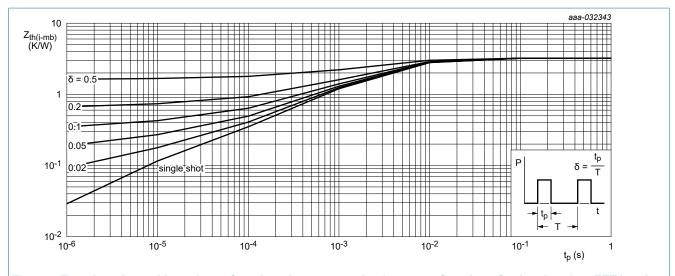


Fig. 4. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FET2

### 10. Characteristics

**Table 7. Characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static charac	teristics FET1 and FET2					
V <sub>(BR)DSS</sub>	drain-source	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	40	-	-	V
	breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = -55 °C	36	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1.5	1.85	2.2	V
$\Delta V_{GS(th)}/\Delta T$	gate-source threshold voltage variation with temperature	25 °C ≤ T <sub>j</sub> ≤ 150 °C	-	-4.2	-	mV/K
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	0.01	5	μΑ
		V <sub>DS</sub> = 16 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 125 °C	-	0.14	10	μΑ
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 16 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	2	100	nA
		V <sub>GS</sub> = -16 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C; <u>Fig. 8</u>	-	11.35	13.6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 175 °C;$ Fig. 9	-	-	26.4	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C}; Fig. 8$	-	14.04	16.9	mΩ
		$V_{GS}$ = 4.5 V; $I_D$ = 10 A; $T_j$ = 175 °C; Fig. 9	-	-	32.8	mΩ
R <sub>G</sub>	gate resistance	f = 1 MHz; T <sub>j</sub> = 25 °C	0.7	1.7	4.2	Ω
Dynamic cha	racteristics FET1 and FE	T2			'	
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V; Fig. 10; Fig. 11	4.7	7.3	10.2	nC
		I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 10 V; Fig. 10; Fig. 11	9	13.9	19.4	nC
		I <sub>D</sub> = 0 A; V <sub>DS</sub> = 0 V; V <sub>GS</sub> = 10 V	-	7.3	-	nC

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Q <sub>GS</sub>	gate-source charge	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V;	1.5	2.5	3.8	nC
Q <sub>GS(th)</sub>	pre-threshold gate- source charge	Fig. 10; Fig. 11	0.8	1.4	2.1	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate- source charge		0.7	1.1	1.6	nC
$Q_{GD}$	gate-drain charge		0.6	2.1	4.2	nC
$V_{GS(pl)}$	gate-source plateau voltage	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; <u>Fig. 10</u> ; <u>Fig. 11</u>	-	2.9	-	V
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz;	539	829	1160	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; <u>Fig. 12</u>	182	280	420	pF
C <sub>rss</sub>	reverse transfer capacitance		11.4	38	84	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 3 \Omega; V_{GS} = 5 \text{ V};$	-	5.6	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5 \Omega$	-	8.1	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	9.1	-	ns
t <sub>f</sub>	fall time		-	6.5	-	ns
Q <sub>oss</sub>	output charge		-	11.5	-	nC
Source-drai	n diode FET1 and FET2		'	'	'	'
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 10 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; <u>Fig. 13</u>	-	0.84	1	V
t <sub>rr</sub>	reverse recovery time	$I_S = 10 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ;	-	21.5	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 20 V; <u>Fig. 14</u>	-	16.2	-	nC
t <sub>a</sub>	reverse recovery rise time		-	9.1	-	ns
t <sub>b</sub>	reverse recovery fall time		-	6.3	-	ns

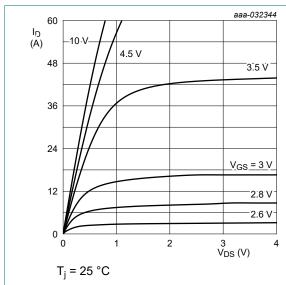


Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values, FET1 and FET2

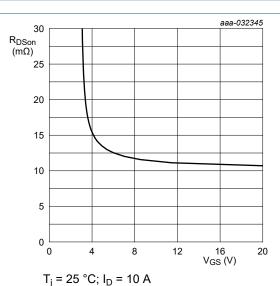


Fig. 6. Drain-source on-state resistance as a function of gate-source voltage; typical values, FET1 and FET2

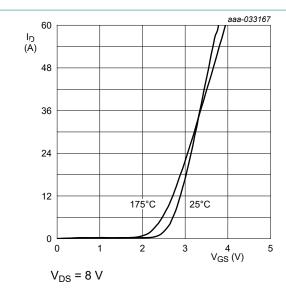


Fig. 7. Transfer characteristics; drain current as a function of gate-source voltage; typical values, FET1 and FET2

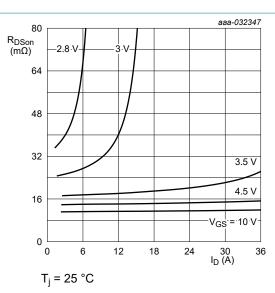


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

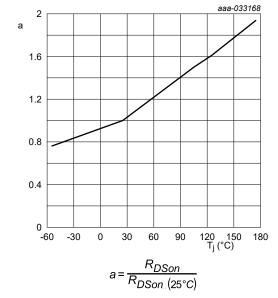


Fig. 9. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

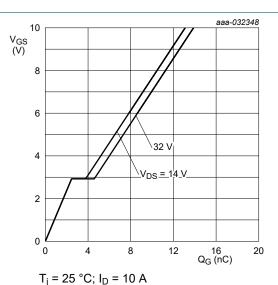


Fig. 10. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

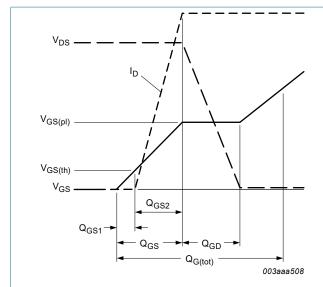


Fig. 11. Gate charge waveform definitions

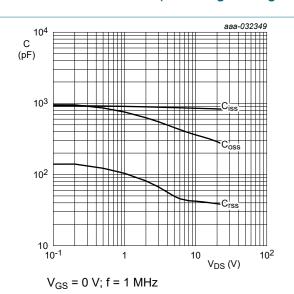


Fig. 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2

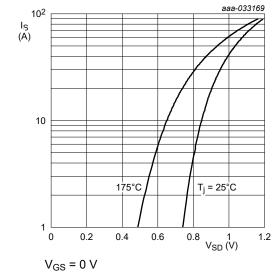


Fig. 13. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values, FET1 and FET2

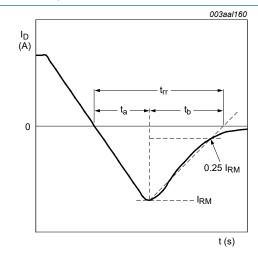
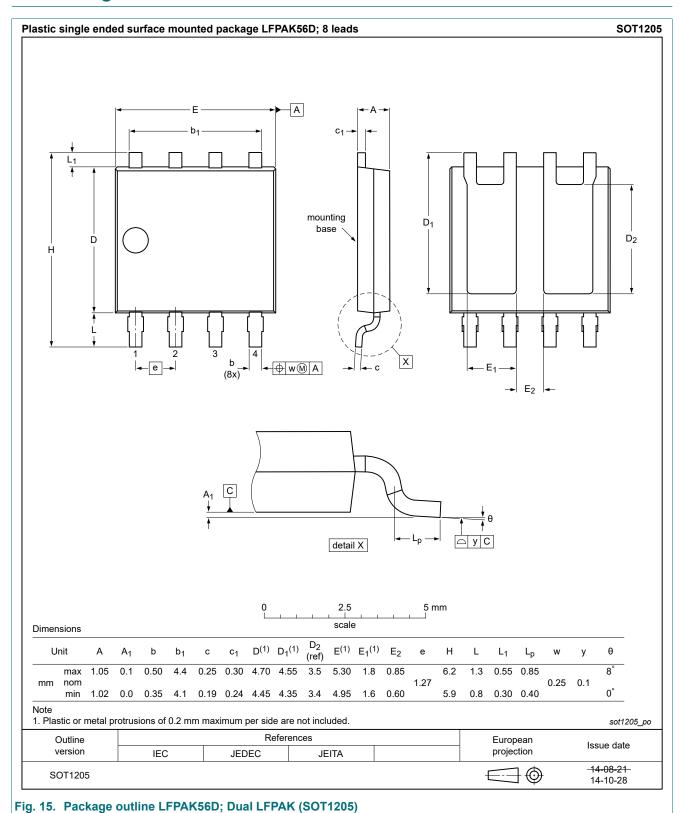
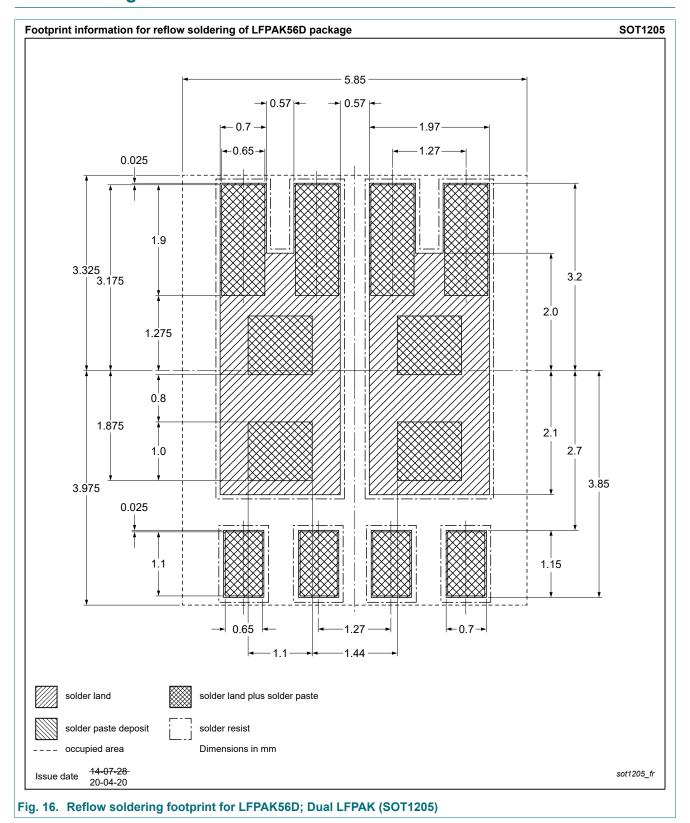


Fig. 14. Reverse recovery timing definition

## 11. Package outline



## 12. Soldering



### 13. Legal information

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Document status [1][2]	Product status [3]	Definition
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